| L Number | Hits | | DB | Time stamp |
|----------|------|--|----------|------------------|
| 1 | 1 | ("6088127").PN. | USPAT | 2002/09/02 10:17 |
| 2 | 1 | (("6088127").PN.) and (ground or trap or interconnect or | USPAT | 2002/09/02 10:17 |
| | | metal or first or second or third or substrate or | 4517(1 | 2002/09/02 10:21 |
| | İ | semiconductor or MOS or transistor or EPI or epitaxial or | | ļ |
| | | oxide or burried or insulating or oxidation) | | |
| 3 | 1 | ("6008127").PN. | USPAT | 2002/09/02 10:42 |
| 4 | 1 | (("6008127").PN.) and (ground or trap or interconnect or | USPAT | 2002/09/02 10:42 |
| | | metal or first or second or third or substrate or | | 2332737732 13:21 |
| | | semiconductor or MOS or transistor or EPI or epitaxial or | | |
| _ | | oxide or burried or insulating or oxidation) | | ! |
| 5 | 1 | (("6008127").PN.) and (ground or trap or low or | USPAT | 2002/09/02 10:51 |
| | | resistance) | | =002,00,02 0.5 |
| 6 | 173 | 257/491 | USPAT | 2002/09/02 10:52 |
| 7 | 126 | 257/624 | USPAT | 2002/09/02 10:52 |
| 8 | 103 | 257/625 | USPAT | 2002/09/02 10:52 |
| 9 | 485 | 257/635 | USPAT | 2002/09/02 10:52 |
| 10 | 293 | 257/637 | USPAT | 2002/09/02 10:52 |
| 11 | 268 | 257/642 | USPAT | 2002/09/02 10:52 |
| 12 | 607 | 257/720 | USPAT | 2002/09/02 10:52 |
| 13 | 1874 | 257/774 | USPAT | 2002/09/02 10:52 |
| - | 39 | (ground adj trap) | USPAT | 2002/08/31 20:26 |
| - | 0 | (burier adj power adj buss) | USPAT | 2002/08/31 20:03 |
| - | 1 | ((ground adj trap)) and (slot and metal and interconnect) | USPAT | 2002/08/31 20:06 |
| • | 1 | ((ground adj trap)) and (opening and metal and | USPAT | 2002/08/31 20:07 |
| | _ | interconnect) | | |
| - | 0 | ((ground adj trap)) and (first adj metal) and (second adj | USPAT | 2002/08/31 20:08 |
| | | metal) and (third adj metal) | | |
| • | 0 | MOS and transistor and ground and (buried adj power) and | USPAT | 2002/08/31 20:09 |
| | | (first adj metal) and (second adj metal) and (third adj metal) | | |
| - | 111 | MOS and transistor and ground and (first adj metal) and | USPAT | 2002/08/31 20:18 |
| i | ا م | (second adj metal) and (third adj metal) | | |
| · | 0 | (MOS and transistor and ground and (first adj metal) and | USPAT | 2002/08/31 20:10 |
| İ | | (second adj metal) and (third adj metal)) and (ground adj | | |
| | | trap) | | |
| - | 1 | (MOS and transistor and ground and (first adj metal) and | USPAT | 2002/08/31 20:17 |
| | | (second adj metal) and (third adj metal)) and (trap and | | 1 |
| | _ [| buried and power) | | |
| | 0 | (MOS and transistor and ground and (first adj metal) and | USPAT | 2002/08/31 20:18 |
| | 1 | (second adj metal) and (third adj metal)) and (trap and | | |
| | 10 | buried and power and oxidation) | 1165 4 = | |
| | 18 | MOS and transistor and ground and (first adj metal) and | USPAT | 2002/08/31 20:18 |
| | | (second adj metal) and (third adj metal) and oxidation | | |
| <u> </u> | 1 | ("4132856").PN. | USPAT | 2002/08/31 20:27 |

9/2/02